

## HEXFET® Power MOSFET

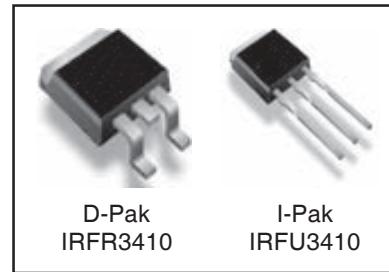
**Applications**

- High frequency DC-DC converters

V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
100V	39mΩ	31A <sup>⑥</sup>

**Benefits**

- Low Gate-to-Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective C<sub>OSS</sub> to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current


**Absolute Maximum Ratings**

Symbol	Parameter	Max.	Units
V <sub>DS</sub>	Drain-Source Voltage	100	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	31 <sup>⑥</sup>	A
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	22	
I <sub>DM</sub>	Pulsed Drain Current <sup>①</sup>	125	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Maximum Power Dissipation	110	W
P <sub>D</sub> @ T <sub>A</sub> = 25°C	Maximum Power Dissipation	3.0	
	Linear Derating Factor	0.71	W°C
dv/dt	Peak Diode Recovery dv/dt <sup>③</sup>	15	V/ns
T <sub>J</sub>	Operating Junction and		°C
T <sub>STG</sub>	Storage Temperature Range	-55 to + 175	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	

**Thermal Resistance**

	Parameter	Typ.	Max.	Units
R <sub>0JC</sub>	Junction-to-Case	—	1.4	°C/W
R <sub>0JA</sub>	Junction-to-Ambient (PCB mount)*	—	40	
R <sub>0JA</sub>	Junction-to-Ambient	—	110	

**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.11	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$ ④
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	34	39	m $\Omega$	$V_{GS} = 10\text{V}, I_D = 18\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$V_{DS} = 100\text{V}, V_{GS} = 0\text{V}$
		—	—	250		$V_{DS} = 80\text{V}, V_{GS} = 0\text{V}, T_J = 150^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{GS} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{GS} = -20\text{V}$

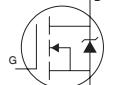
**Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

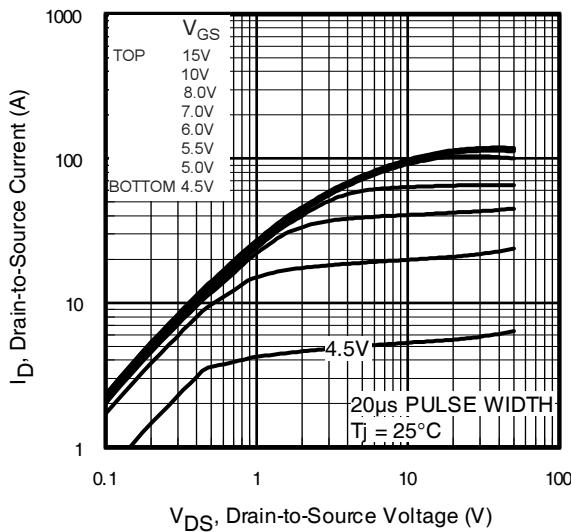
	Parameter	Min.	Typ.	Max.	Units	Conditions
$g_{fs}$	Forward Transconductance	33	—	—	S	$V_{DS} = 25\text{V}, I_D = 18\text{A}$
$Q_g$	Total Gate Charge	—	37	56	nC	$I_D = 18\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	10	—		$V_{DS} = 50\text{V}$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	11	—		$V_{GS} = 10\text{V}$ , ④
$t_{d(\text{on})}$	Turn-On Delay Time	—	12	—		$V_{DD} = 50\text{V}$
$t_r$	Rise Time	—	27	—	ns	$I_D = 18\text{A}$
$t_{d(\text{off})}$	Turn-Off Delay Time	—	40	—		$R_G = 9.1\Omega$
$t_f$	Fall Time	—	13	—		$V_{GS} = 10\text{V}$ ④
$C_{iss}$	Input Capacitance	—	1690	—		$V_{GS} = 0\text{V}$
$C_{oss}$	Output Capacitance	—	220	—	pF	$V_{DS} = 25\text{V}$
$C_{rss}$	Reverse Transfer Capacitance	—	26	—		$f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	1640	—		$V_{GS} = 0\text{V}, V_{DS} = 1.0\text{V}, f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	130	—		$V_{GS} = 0\text{V}, V_{DS} = 80\text{V}, f = 1.0\text{MHz}$
$C_{oss \text{ eff.}}$	Effective Output Capacitance	—	250	—		$V_{GS} = 0\text{V}, V_{DS} = 0\text{V to } 80\text{V}$ ⑤

**Avalanche Characteristics**

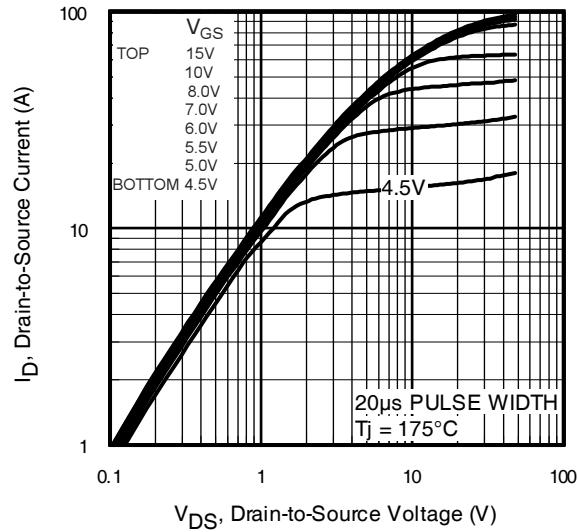
	Parameter	Typ.	Max.	Units
$E_{AS}$	Single Pulse Avalanche Energy ②	—	140	mJ
$I_{\text{AR}}$	Avalanche Current ①	—	18	A

**Diode Characteristics**

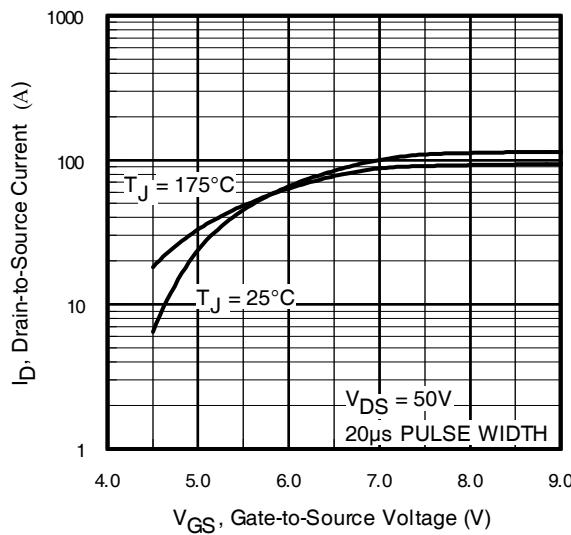
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_s$	Continuous Source Current (Body Diode)	—	—	31 ⑥	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{sM}$	Pulsed Source Current (Body Diode) ①	—	—	125		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_s = 18\text{A}, V_{GS} = 0\text{V}$ ④
$t_{rr}$	Reverse Recovery Time	—	84	—	ns	$T_J = 25^\circ\text{C}, I_F = 18\text{A}$
$Q_{rr}$	Reverse Recovery Charge	—	260	—	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ④
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_s + L_D$ )				



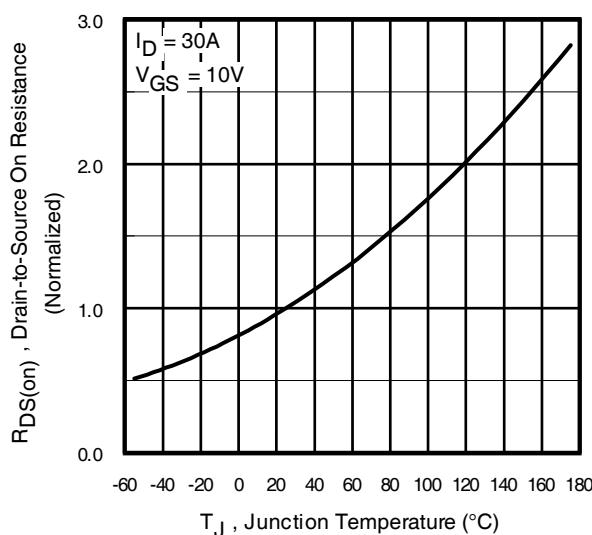
**Fig 1.** Typical Output Characteristics



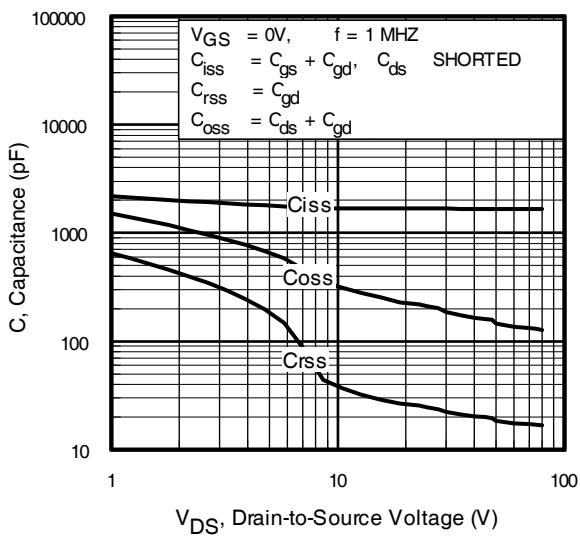
**Fig 2.** Typical Output Characteristics



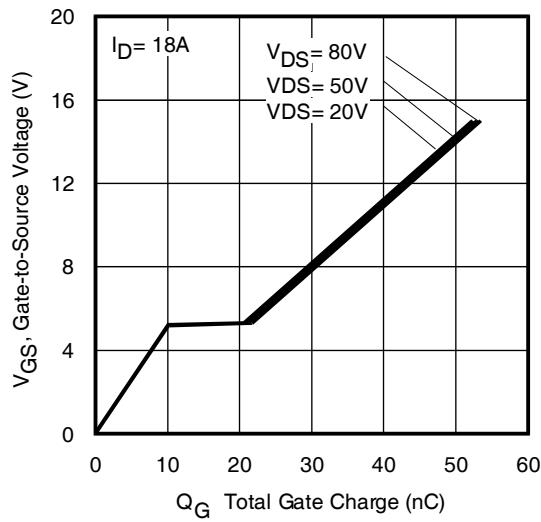
**Fig 3.** Typical Transfer Characteristics



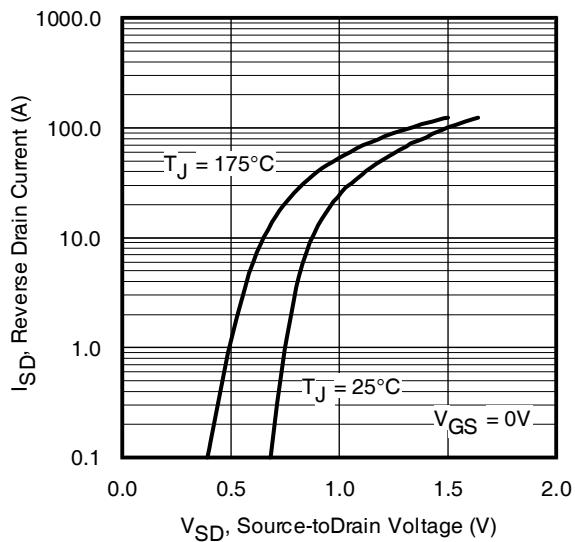
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



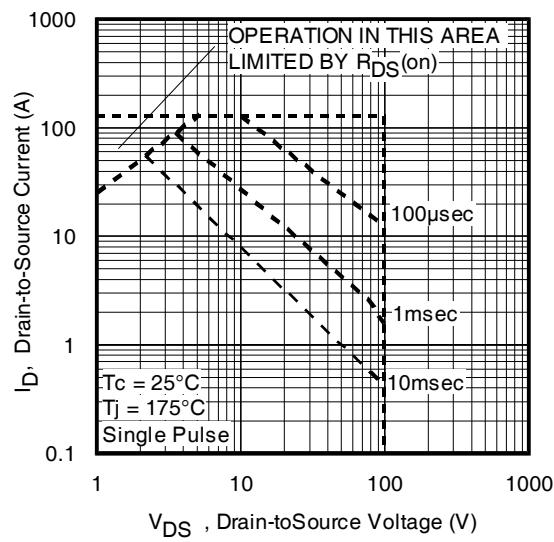
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



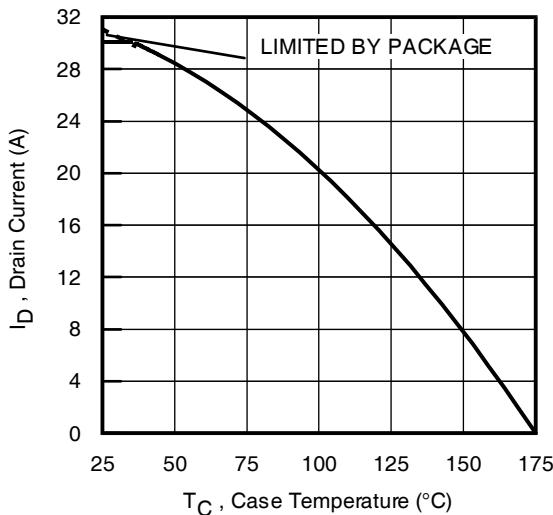
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



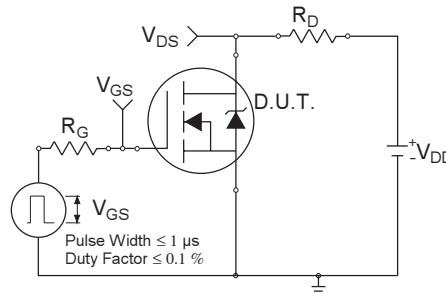
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



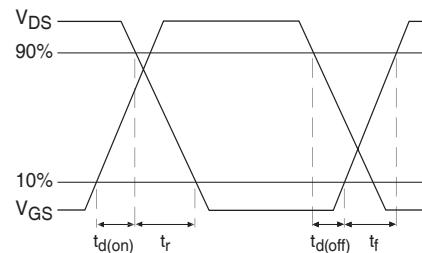
**Fig 8.** Maximum Safe Operating Area



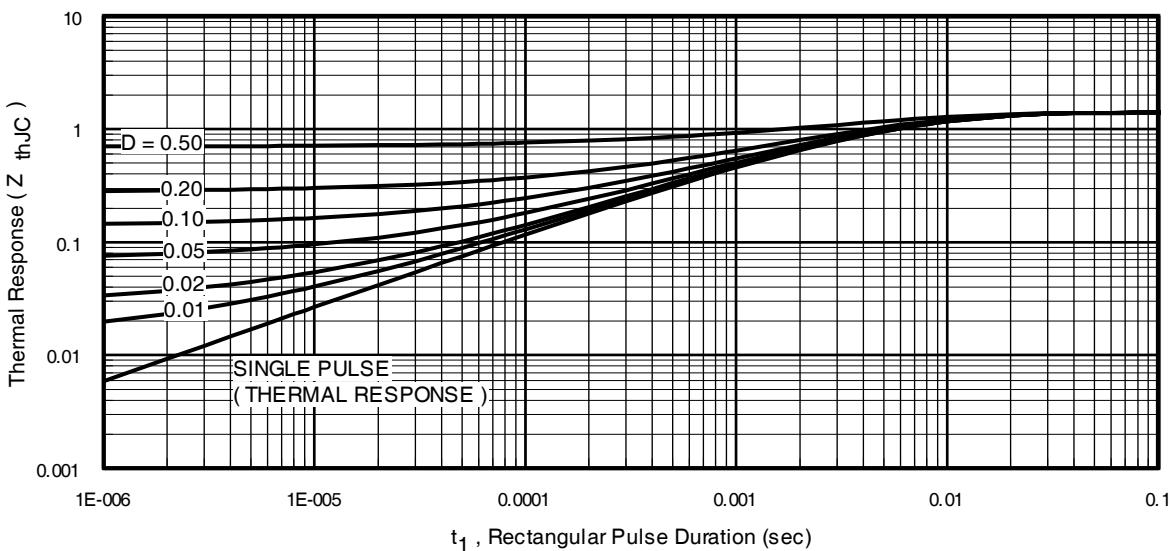
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



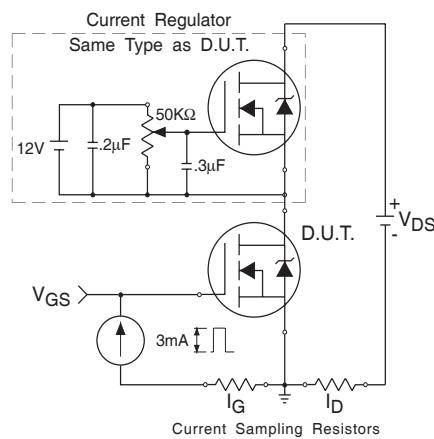
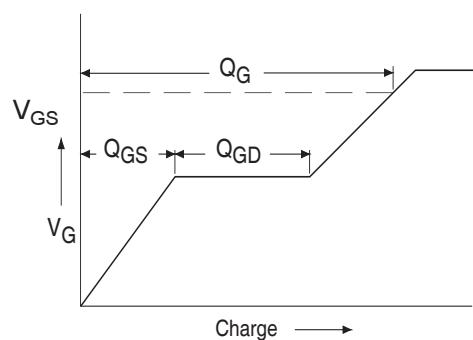
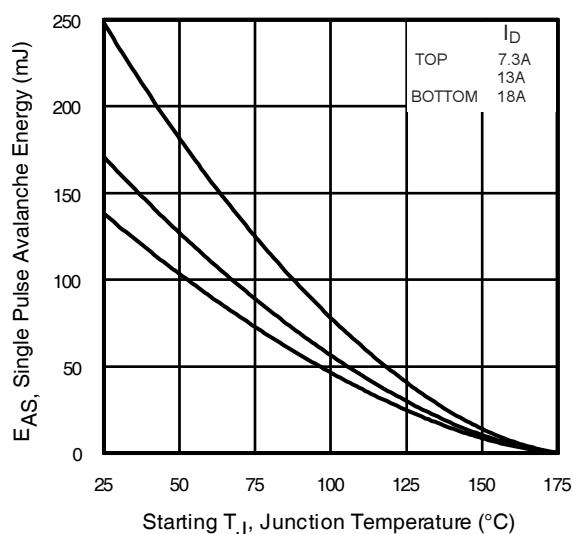
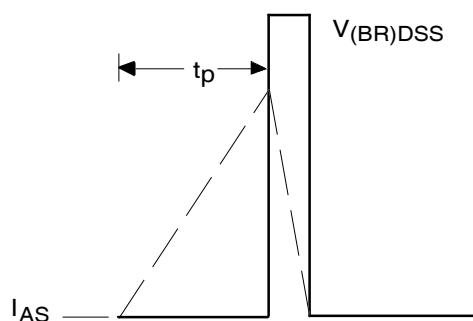
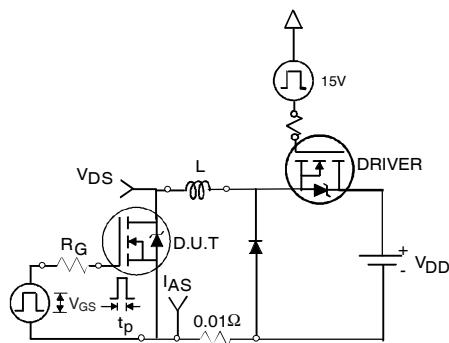
**Fig 10a.** Switching Time Test Circuit

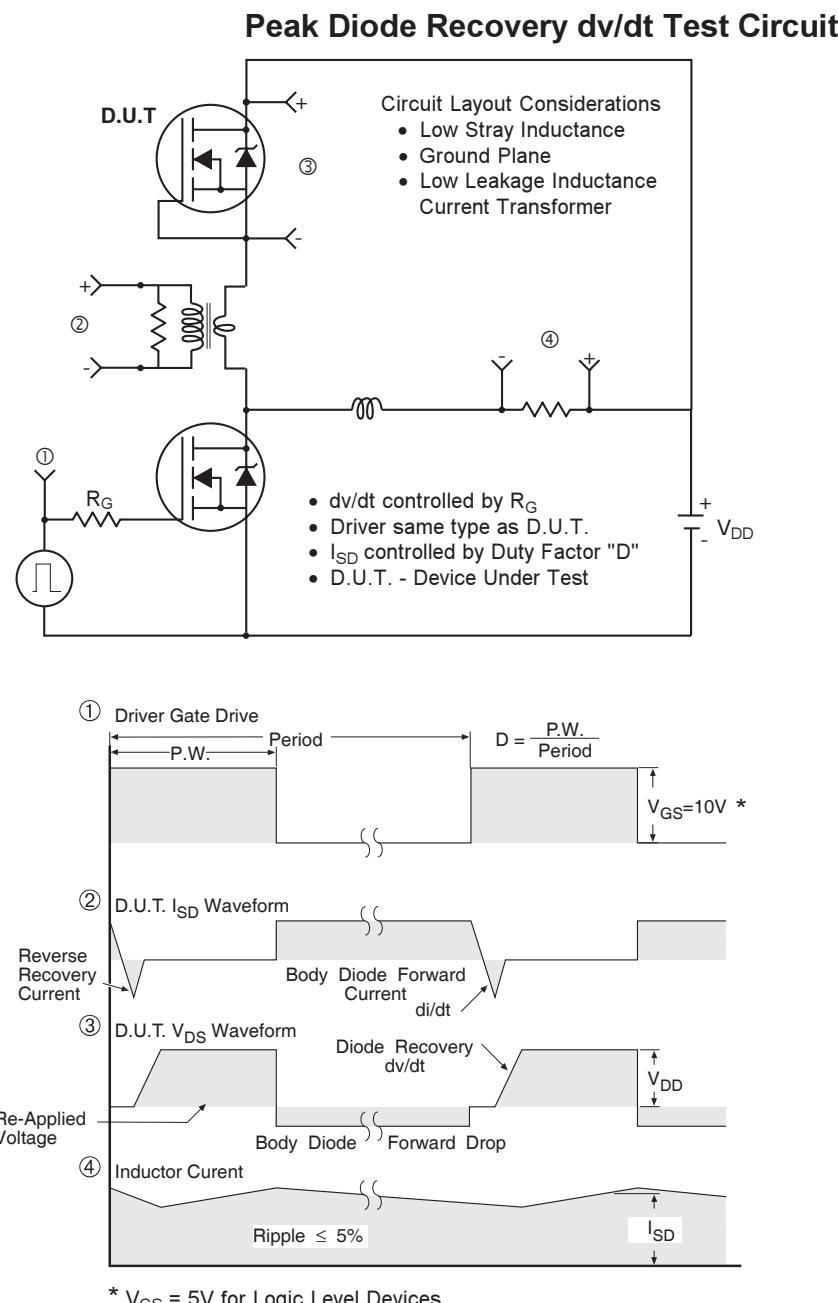


**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

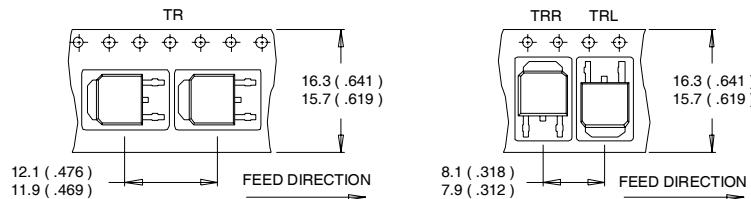




**Fig 14.** For N-Channel HEXFET® Power MOSFETs

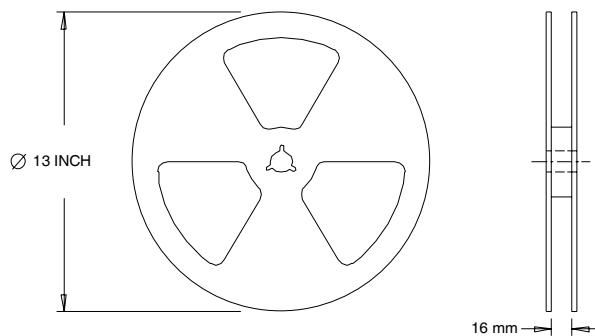
## D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.

**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.85\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 18\text{A}$ .
- ⑤  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$
- ③  $I_{SD} \leq 18\text{A}$ ,  $di/dt \leq 360\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  
 $T_J \leq 175^\circ\text{C}$
- ⑥ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 30A.
- \* When mounted on 1" square PCB (FR-4 or G-10 Material).  
For recommended footprint and soldering techniques refer to application note #AN-994.